

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/788,831	CHOI, KYUNG-JU
	Examiner	Art Unit
	Maria Veronica D. Ewald	1722

ISSUE CLASSIFICATION				
ORIGINAL		CROSS REFERENCE(S)		
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	
425	72.2	425	131.5	382.2
INTERNATIONAL CLASSIFICATION		156	178	363
B	2	8	B	5/00
			/	
			/	
			/	
			/	
<i>Maria Veronica D. Ewald</i> <i>12-20-06</i> (Assistant Examiner) (Date)		<i>JAT</i> <i>12-20-06</i> (Primary Examiner) SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER (Date)		Total Claims Allowed: 20
<i>JAT</i> (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1
				O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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4		5	34	64		94	
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6		7	36	66		96	
7		8	37	67		97	
8		9	38	68		98	
9		10	39	69		99	
10		11	40	70		100	
11		12	41	71		101	
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13		14	43	73		103	
14		15	44	74		104	
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18		19	48	78		108	
19		20	49	79		109	
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							210